NOTES:

1. SUBSTRATE MATERIAL: FUSED SILICA

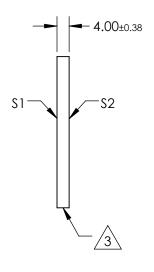
2. COATING (APPLY ACROSS CLEAR APERTURE)

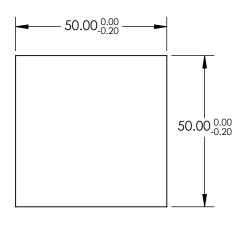
S1: R(abs)= 30% ±5% @ 350nm, 45° AOI R(avg)= 30% ±10% OVER 250 - 450nm, 45° AOI T(abs)= 70% ±5% @ 350nm, 45° AOI T(avg)= 70% ±10% OVER 250 - 450nm, 45° AOI

S2: BBAR (R(avg) <1%, R(abs) <2% OVER 250 - 450nm), 45° AOI



4. ROHS COMPLIANT





FOR INFORMATION ONLY: DO NOT MANUFACTURE PARTS TO THIS DRAWING

SPECIFICATIONS SUBJECT TO CHANGE WITHOUT NOTICE DIMENSIONS ARE FOR REFERENCE ONLY

REV. A	\$1	\$2]			Edmund Optic	C®
SHAPE	PLANO	PLANO					<i>,</i> ⊙
CLEAR APERTURE	42.50 x 42.50	42.50 x 42.50		1		50 x 50mm, 30R/70T, UV PLATE BEAMSP	ITTER
SURFACE QUALITY	60-40	60-40	THIRD ANGLE PROJECTION		TITLE	30 X 30Hilli, 30K/701, 0 V 1 E/XIE BE/XIVISI EITTEK	
SURFACE FLATNESS	1λ	1λ					CLIEFT
BEVEL	PROTECTED AS NEEDED	PROTECTED AS NEEDED	ALL DIMS IN	mm	DWG NO	48199	SHEET 1 OF 1